

**Notice of References Cited**

Application/Control No.

10/784,782

Applicant(s)/Patent Under  
Reexamination  
HAN ET AL.

Examiner

Stephen G. Sherman

Art Unit

2629

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,009,584	03-2006	Kim, Jung Hun	345/60
*	B	US-2003/0222835	12-2003	Yoon et al.	345/60
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 3098586 A1	11-2003	World Intellect	TAE et al.	
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	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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